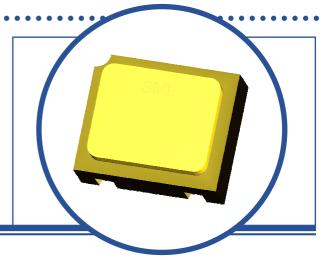
SMALL SIGNAL NPN RF TRANSISTOR



BFR92, BFR92A

- Silicon Planar Epitaxial NPN Transistor
- Hermetic Ceramic Surface Mount Package (SOT23 Compatible)
- Suitable For UHF Applications Up To 1.0GHz
- Space Level and High-Reliability Screening Options Available



ABSOLUTE MAXIMUM RATINGS (T_A = 25°C unless otherwise stated)

Vсво	Collector – Base Voltage		20V	
V_{CEO}	Collector – Emitter Voltage	15V		
V_{EBO}	Emitter – Base Voltage	2V		
IC	Collector Current	25mA		
I_{CM}	Collector Peak Current	35mA		
I_{B}	Base Current		4mA	
P_{D}	Total Power Dissipation at	$T_A = 25^{\circ}C$	250mW	
		Derate Above 25°C	2mW/°C	
TJ	Junction Temperature Range		-65 to +150°C	
T _{stg}	Storage Temperature Range		-55 to +150°C	

THERMAL PROPERTIES

Symbols	Parameters	Min.	Тур.	Мах.	Units
R _{0JA}	Thermal Resistance, Junction To Ambient			500	°C/W





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ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise stated)

Symbols	Parameters	Test Conditions		Min.	Тур.	Max.	Units
V _(BR) CBO (1)	Collector-Base Breakdown Voltage	I _C = 10μΑ	I _E = 0	20			
V _(BR) CEO (1)	Collector-Emitter Breakdown Voltage	I _C = 1.0mA	I _B = 0	15			V
V _{(BR)EBO} (1)	Collector-Emitter Breakdown Voltage	I _C = 10μA	I _C = 0	2			
I _{CBO}	Collector-Base Cut-Off Current	V _{CB} = 10V	I _E = 0			50	
I _{CEO}	Collector-Emitter Cut-Off Current (BFR92A)	V _{CB} = 10V	I _B = 0			50	nA
I _{EBO}	Emitter-Base Cut-Off Current (BFR92A)	V _{EB} = 1.0V	I _C = 0			10	
		I _C = 14mA	$V_{CE} = 10V$				
h _{FE} (1)	Forward-current transfer ratio		BFR92	25			
			BFR92A	40			

DYNAMIC CHARACTERISTICS

f _T ⁽²⁾	Transition Frequency	$I_C = 14mA$ $V_{CE} = 10V$ $f = 500MHz$	5	GHz
C _{EB} ⁽²⁾	Emitter Base Capacitance	$V_{EB} = 0.5V$, $I_{C} = 0$, $f = 1.0MHz$	0.4	
C _{CB} ⁽²⁾	Collector Base Capacitance	$V_{CB} = 10V, I_E = 0, f = 1.0MHz$		F
		BFR92	0.5	pF
		BFR92A	0.6	
	Noise Figure	I _C = 2mA, V _{CE} = 10V		
N _F ⁽²⁾		f = 500MHz for BFR92	2.4	
		f = 800MHz for BFR92A	1.8	
G _{UM} ⁽²⁾	Maximum Unilateral Power Gain	I _C = 14mA, V _{CE} = 10V		
		f = 500MHz for BFR92	18	dB
		f = 800MHz for BFR92A	16	ив
d _{IM3} ⁽²⁾	Intermodulation Distortion	I _C = 14mA, V _{CE} = 10V		
		$R_L = 500\Omega, V_O = 150mV$		
		f = 500MHz for BFR92	-60	
		f = 800MHz for BFR92A	-60	

Notes

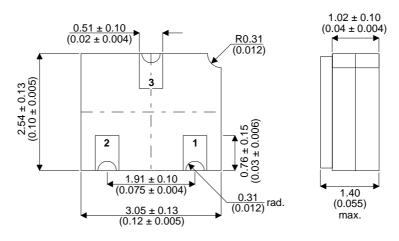
- (1) Pulse Width \leq 300us, $\delta \leq$ 2%
- (2) By Design, not measured as a production test.

SMALL SIGNAL NPN RF TRANSISTOR BFR92, BFR92A



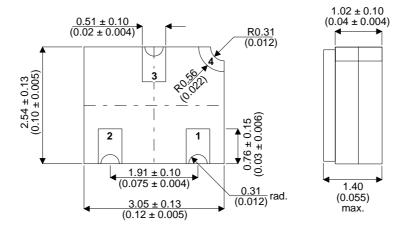
MECHANICAL DATA

Dimensions in mm (inches)



C₁A (Underside View)

Pad 1 - Base Pad 2 - Emitter Pad 3 - Collector



C₁B (Underside View)

Pad 1 - Base Pad 2 - Emitter Pad 3 – Collector Pad 4 - Lid Contact Ground *

Other Package Outlines may be available – Contact Semelab Sales to Enquire

Semelab Limited Telephone +44 (0) 1455 556565

Coventry Road, Lutterworth, Leicestershire, LE17 4JB Fax +44 (0) 1455 552612

Email: sales@semelab-tt.com

Website: http://www.semelab-tt.com

^{*} The additional contact provides a connection to the lid in the application. Connecting the metal lid to a known electrical potential stops deep dielectric discharge in space applications; see the Space Weather link www.semelab.co.uk/mil/lcc1_4 on the Semelab web site. Package variant to be specified at order.

SMALL SIGNAL NPN RF TRANSISTOR BFR92, BFR92A



SCREENING OPTIONS

Space Level (JQRS/ESA) and High Reliability options are available in accordance with the <u>High Reliability and Screening Options Handbook</u> available for download from the from the TT electronics Semelab web site.

ESA Quality Level Products are based on the testing procedures specified in the generic ESCC 5000 and in the corresponding part detail specifications.

Semelabs QR216 and QR217 processing specifications (JQRS), in conjunction with the companies ISO 9001:2000 approval present a viable alternative to the American MIL-PRF-19500 space level processing.

QR217 (Space Level Quality Conformance) is based on the quality conformance inspection requirements of MIL-PRF-19500 groups A (table V), B (table VIa), C (table VII) and also ESA / ESCC 5000 (chart F4) lot validation tests.

QR216 (Space Level Screening) is based on the screening requirements of MIL-PRF-19500 (table IV) and also ESA /ESCC 5000 (chart F3).

JQRS parts are processed to the device data sheet and screened to QR216 with conformance testing to Q217 groups A and B in accordance with MIL-STD-750 methods and procedures.

Additional conformance options are available, for example Pre-Cap Visual Inspection, Buy-Off Visit or Data Packs. These are chargeable and must be specified at the order stage (See Ordering Information). Minimum order quantities may apply.

Alternative or additional customer specific conformance or screening requirements would be considered. Contact Semelab sales with enquires.

MARKING DETAILS

Screened parts are typically marked with specification number, serial number (or week of seal) as shown in the example below. All non screened parts are printed with three characters only eg. 92A.

Customer specific marking requirements can be arranged at time of order but is approximately limited to two lines of 7 Characters. This is to ensure text remains readable..

Example Marking:



ORDERING INFORMATION

Part number is built from part and screening level. The part number can be extended to include the additional options as shown below.

Type – See Electrical Stability Characteristics Table Package Variant – See Mechanical Data Screening Level – See Screening Options (ESA / JQRS)

Additional Options:

Customer Pre-Cap Visual Inspection	.CVP
Customer Buy-Off visit	.CVB
Data Pack	.DA
Solderability Samples	:SS
Scanning Electron Microscopy	.SEM
Radiography (X-ray)	.XRAY
Total Dose Radiation Test	.RAD
MIL-PRF-19500 (QR217)	
Group B charge	.GRPB
Group B destructive mechanical samples	.GBDM (12 pieces)
Group C charge	.GRPC
Group C destructive electrical samples	.GCDE (12 pieces)
Group C destructive mechanical samples	.GCDM (6 pieces)
ESA/ESCC	
Lot Validation Testing (subgroup 1) charge	.LVT1
LVT1 destructive samples (environmental)	.L1DE (15 pieces)
LVT1 destructive samples (mechanical)	.L1DM (15 pieces)
Lot Validation Testing (subgroup 2) charge	.LVT2
LVT2 endurance samples (electrical)	.L2D (15 pieces)
Lot Validation Testing (subgroup 3) charge	.LVT3
LVT3 destructive samples (mechanical)	.L3D (5 pieces)
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Additional Option Notes:

- 1) All 'Additional Options' are chargeable and must be specified at order stage.
- 1) All Additional Options are chargeable and must be specified at order stage.
 2) When Group B,C or LVT is required, additional electrical and mechanical destructive samples must be ordered
- All destructive samples are marked the same as other production parts unless otherwise requested.

Example ordering information:

The following example is for the 4 pad packaged part option with, JQRS screening, additional Group C conformance testing and a Data pack.

Part Numbers:

BFR92AC1B-JQRS (Include quantity for flight parts)
BFR92AC1B-JQRS.GRPC (chargeable conformance option)
BFR92AC1B-JQRS.GCDE (charge for destructive parts)
BFR92AC1B-JQRS.GCDM (charge for destructive parts)
BFR92AC1B-JQRS.DA (charge for Data pack)

Customers with any specific requirements (e.g. marking, package or screening) may be supplied with a similar alternative part number (there is maximum 20 character limit to part numbers). Requirements for deep dielectric discharge variant (C1B) must be specified at time of order. Contact Semelab sales with all enquiries

High Reliability and Screening Options Handbook link: http://www.semelab.co.uk/pdf/misc/documents/hirel_and_screening_options.pdf